Monoclinic La₂AlGe₆ and Isotypes, a Vacancy Variant of the Orthorhombic SmNiGe₃ Type

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Abstract. $La_2Al_{1+x}Ge_{6-x}$ [x = 0.60 (4)], $M_r = 712.98$, monoclinic, mS36, (12) $C2/m - j^2 i^5$, a = 8.373 (2), b = 8.833 (2), c = 10.887 (3) Å, $\beta = 101.34$ (2)°, V = 789.4 (2) Å³, Z = 4, $D_x = 5.999$ Mg m⁻³, λ (Mo K α) = 0.71073 Å, $\mu = 32.30$ mm⁻¹, F(000) = 1230, T = 300 K, R = 0.040 and wR = 0.031 for 859 contributing unique reflections. Isotypes are found for $R_2Al_{1+x}Ge_{6-x}$ with R = Ce, Pr, Nd, Sm and Gd. This new structure type is a vacancy variant of the orthorhombic SmNiGe₃ structure and can be considered as an intergrowth of AlB₂-, deformed Po-and partially vacant inverse-ThCr₂Si₂-type slabs. It is a slab stacking variant of the pseudobinary $Ce_2(Ge_{0.9}Ge_{0.1})_7$ type, another vacancy variant of the SmNiGe₃ type.

Introduction. The La-poor part (< 35 at.% La) of the La–Al–Ge ternary phase diagram was investigated by Muravyeva & Zarechnyuk (1970). Of the five compounds reported, the crystal structures of four compounds are known: hexagonal LaAl₂Ge₂ with CaAl₂Si₂ type, hexagonal LaAl₂ $_-x$ Ge_x (0·2 ≤ x ≤ 0·5) with AlB₂ type, tetragonal LaAlGe with α -ThSi₂ type (or an ordered variant) and orthorhombic La₂Al₃Ge₄ with Ba₂Cd₃Bi₄ type. For more details see Zhao & Parthé (1991). Here we report on the structure determination of the fifth compound with nominal composition 'LaAlGe₃'.

Experimental. A sample of nominal composition 'LaAlGe₃' was prepared by arc melting under argon atmosphere (La, Al and Ge: 99·99%). The weight loss was 0·4%. The sample was annealed at 770 K for two months in an Ar-filled silica tube. A regular-shaped single crystal [±(100): 0·016, ±(010): 0·040, ±(001): 0·016 mm], obtained from the annealed sample, was mounted on a Philips PW1100 automatic four-circle diffractometer; Mo $K\alpha$ radiation with graphite monochromator. The unit-cell parameters were refined from 2θ values of 28 reflections (Mo $K\alpha$, $\lambda = 0.71073$ Å, $20 < 2\theta < 40^{\circ}$) using *LATCON* (Schwarzenbach, 1966). 2660 reflections were collected out to $(\sin\theta/\lambda) = 0.703$ Å⁻¹ ($0 \le h \le 10^{\circ}$).

11, $0 \le k \le 12$, $-15 \le l \le 15$ and the anti-reflections) in the ω -2 θ scan mode, yielding 1228 unique reflections ($R_{int} = 0.017$). Two standard reflections ($\overline{2}\overline{2}\overline{1}$ and $0\overline{4}0$) were measured with max. intensity variations 0.6 and 0.4% respectively. Absorption correction was made using ABSORB (Davenport, Spadaccini & Stewart, 1990) with max. and min. transmission factors of 0.4068 and 0.2178. The anomalous-dispersion coefficients were taken from International Tables for X-ray Crystallography (1974, Vol. IV). Systematic absences led to the following possible space groups: C2, Cm and C2/m (International Tables for Crystallography, 1983, Vol. A). The structure was solved in space group C2/m using MULTAN87 (Debaerdemaeker, Germain, Main, Tate & Woolfson, 1987). The abnormally high atomic displacement parameters of three Ge sites in the starting refinement indicated that these positions should have some Al atoms substituting for the Ge atoms. The refined composition was confirmed by the microprobe analysis which gave the composition as $La_{0.20(1)}Al_{0.17(3)}Ge_{0.63(2)}$. The full-matrix leastsquares refinement was based on |F| values using CRYLSQ (Olthof-Hazekamp, 1990). 42 variables, including isotropic and anisotropic atomic displacement parameters, refined to R = 0.040 and wR= 0.031 [$w = 1/\sigma^2(|F_{rel}|)$, S = 1.985] considering 859 contributing unique reflections with $|F_{rel}| >$ $3\sigma(|F_{rel}|)$. Secondary-extinction correction parameter (Gaussian distribution of mosaic spread) was refined to G = 0.0195 (3). The max. shift/e.s.d. in the last cycle was 0.0003.* Final residual electron density $+4.5(-4.1) e Å^{-3}$. The programs used to refine the structure are all from the XTAL3.0 system (Hall & Stewart, 1990). The atomic positional parameters were standardized by using the STRUCTURE TIDY (Gelato & Parthé, 1987) program. The atomic posi-

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^{*} Lists of structure factors and anisotropic displacement parameters have been deposited with the British Library Document Supply Centre as Supplementary Publication No. SUP 54084 (9 pp.). Copies may be obtained through The Technical Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

tional and displacement parameters are given in Table 1 and the interatomic distances up to 3.45 Å in Table 2.

Isotypic compounds

The five isotypic $R_2Al_{1+x}Ge_{6-x}$ compounds listed in the *Abstract* and in Table 3 were also prepared by the arc-melting method under Ar atmosphere. The samples were annealed at 773 K for two weeks in an Ar-filled silica tube. The observed powder patterns

Table 1.	Atomic positional	l and displac	ement param-
eters for	$La_2Al_{1+x}Ge_{6-x}$	[x = 0.60 (4)])] with space
	group	C2/m	

The isotropic atomic displacement factors are expressed as $T = \exp[-2\pi^2 U(\sin\theta/\lambda)^2]$. E.s.d.'s are given in parentheses.

	wyckoff position	x	у	z	$U(Å^2 \times 10^2)$
La	8(j)	0.08527 (8)	0.24828 (9)	0.33612 (6)	0.72 (3)
X(1)	8(j)	0.2783 (2)	0.2131(1)	0.1125 (1)	1.10 (4)*
X(2)	4(<i>i</i>)	0.0694 (3)	0	0.1123 (2)	1.01 (7)*
Ge(1)	4(<i>i</i>)	0.1460 (3)	0	0.5640 (2)	0.96 (9)
Ge(2)	4(i)	0.3597 (3)	0	0.4195 (2)	1.15 (9)
X(3)	4(<i>i</i>)	0.4869 (3)	0	0.1133 (2)	1.23 (7)*
Al	4(i)	0.8006 (7)	0	0.1952 (5)	1.3 (2)

Site occupancy: $X(1) = Ge_{0.91(1)}Al_{0.09(1)}; \quad X(2) = Ge_{0.77(1)}Al_{0.23(1)}; \quad X(3) = Ge_{0.81(1)}Al_{0.19(1)}.$

* Atomic displacement parameters refined isotropically.

Table	2.	Interatomic	distances	ир	to	3·45 Å	in
		$La_2Al_{1+x}Ge$	$e_{6-x} [x=0]$	·60 ((4)]		

I a—	Ge(2)	3.164 (2)	Ge(1)-	- Ge(1)	2.566 (3)
	Ge(2)	3.177(2)	00(1)	AL	2.571(6)
	X(1)	3.191(2)		Ge(2)	2.605(3)
	X(1)	3.192 (2)		21.9	3.108(2)
	Ge(1)	3,108 (2)		21.2	3,251(2)
	$G_{e}(1)$	3.751(2)		21.a	3,275(2)
		3231(2)	$C_{-}(2)$	2La	3.273(2)
	X(2)	3.201 (2)	Ge(2)-	- Ge(1)	2.605 (3)
	Ge(1)	3.275 (2)		Ge(2)	2.641 (3)
	X(3)	3.275 (2)		2La	3.164 (2)
	Al	3.377 (4)		2La	3.177 (2)
	Al	3.411 (5)		2La	3.428 (2)
	Ge(2)	3.428 (2)			
X(1)—	X(1)	2.490 (2)	X(3)—	X(3)	2.518 (3)
	X(3)	2.567 (2)		2X(1)	2.567 (2)
	X(2)	2.569 (2)		Al	2.602 (6)
	Al	2.684 (2)		2La	3.275 (2)
	La	3.191 (2)	Al—	Ge(1)	2.571 (6)
	La	3.192 (2)		X(2)	2.584 (2)
X(2)—	X(2)	2.493 (3)		X(3)	2.602 (6)
	2X(1)	2.569 (2)		2X(1)	2.684 (2)
	Al	2.584 (7)		2La	3.377 (4)
2	2La	3.261 (2)		2La	3.411 (5)

were compared with simulated powder diagrams calculated using LAZY PULVERIX (Yvon, Jeitschko & Parthé, 1977). The unit-cell parameters for the $R_2Al_{1+x}Ge_{6-x}$ phases isotypic with $La_2Al_{1+x}Ge_{6-x}$ were refined from either single-crystal data (R = Ce, Pr and Sm) or Guinier film data (R = Nd and Gd) of the annealed samples. The single-crystal data were measured and refined by using the same method as for the $La_2Al_{1+x}Ge_{6-x}$ crystal. No efforts were made to determine the homogeneity range for any of the isotypic phases. The films were measured with a film reader using an internal Si standard (a = 5.4308 Å) and LATCON (Schwarzenbach, 1966) was used for the refinement.

Discussion. The $La_2Al_{1+x}Ge_{6-x}$ structure is a slightly distorted vacancy variant of the SmNiGe₃ type (Bodak, Pecharskii, Mruz, Zavodnik, Vitvits'kaya & Salamakha, 1985) or its lower symmetry variant, the ScNiSi₃ type (Kotur, Bodak, Mys'kiv & Gladyshevskii, 1977). To understand the construction of the $La_2Al_{1+x}Ge_{6-x}$ structure and its relation to the SmNiGe₃ type, it is convenient to discuss first the SmNiGe₃ structure, shown in a projection along [001] on the left-hand side of Fig. 1(*a*). This structure (or ScNiSi₃) can be considered as an intergrowth of three different kinds of slabs (Grin', Yarmolyuk & Gladyshevskii, 1982):

(a) The Po-type slabs are built up of Ge atoms only.

(b) The inverse-ThCr₂Si₂-type slabs formed with rare-earth, Ni and Ge atoms, are built up as the ThCr₂Si₂-type slabs but with Cr and Si sites having been interchanged.* The Ni atoms are at the centres of the compressed square antiprisms of composition Sm_4Ge_4 . The upper and lower interfaces of the inverse-ThCr₂Si₂-type slab are different. The one

* The term 'inverse-ThCr₂Si₂-type' has been applied to $CaZn_2Al_2$ (Cordier, Czech & Schäfer, 1984) where the Al atoms occupy the tetrahedral Cr sites (corresponding sites in inverse-ThCr₂Si₂-type slabs will be referred to as *t* sites hereafter) and Zn the square antiprismatic Si sites (*a* sites). No ternary rare-earth-transition-metal silicide or germanide structures are known which are built up exclusively of inverse-ThCr₂Si₂-type slabs; however, it is possible to have an intergrowth with their rare-earth interfaces of a regular and an inverse-ThCr₂Si₂-type slab, *e.g.* in LaIr₂Si₂ HT (Braun, Engel & Parthé, 1983) with CaBe₂Ge₂ type. Inverse-ThCr₂Si₂-type slabs are observed in many other intergrowth structures.

Table 3. Unit-cell parameters for $La_2Al_{1+x}Ge_{6-x}$ and its isotypes

E.s.d.'s are given in parentheses

Compound	x	a (Å)	b (Å)	c (Å)	β (°)	V (Å ³)
$La_2Al_{1+x}Ge_{6-x} = 0$	·60 (4)	8.373 (2)	8.833 (2)	10.887 (3)	101.34 (2)	789.4 (2)
$Ce_2Al_{1+x}Ge_{6-x}$		8.292 (2)	8.691 (1)	10.739 (3)	101.15 (2)	759.3 (2)
$Pr_2Al_{1+x}Ge_{6-x}$		8·244 (4)	8.630 (4)	10.711 (5)	101.09 (4)	747.8 (4)
$Nd_2Al_{1+x}Ge_{6-x}$		8.220 (5)	8.623 (5)	10.671 (5)	101.05 (8)	742.4 (8)
$Sm_2Al_{1+x}Ge_{6-x}$		8.105 (1)	8.458 (1)	10.613 (2)	101.00 (2)	714.2 (2)
$Gd_2Al_{1+x}Ge_{6-x}$		8.041 (3)	8.351 (5)	10.546 (3)	100.81 (3)	695.5 (5)

consisting of rare-earth atoms acts as interface for an intergrowth with the AlB_2 -type slab, while the other one, consisting of Ge atoms, serves as common interface with the Po-type slab.

(c) The AlB_2 -type slabs consists of Sm and Ge atoms with the Ge atoms at the centres of the trigonal rare-earth prisms.

In one unit cell of SmNiGe₃ eight slabs are intergrown along [010] in the sequence:

 $Po-inverse-ThCr_{2}Si_{2}-AlB_{2}-inverse-ThCr_{2}Si_{2}-Po-inverse-ThCr_{2}Si_{2}-AlB_{2}-inverse-ThCr_{2}Si_{2}.$

Two vacancy variants of the SmNiGe₃ type have been reported. The first was found for Ce₂CuGe₆ (Konyk, Salamakha, Bodak & Pecharskii, 1988) which is shown in a projection along [100] on the right-hand side of Fig. 1(*a*). As was pointed out by Pani & Fornasini (1990) this structure can be considered as an intergrowth of four different kinds of slabs along [001] in the sequence Po-CaF₂-AlB₂inverse-ThCr₂Si₂-Po-CaF₂-AlB₂-inverse-ThCr₂Si₂.* The new CaF₂-type slab is actually an inverse-

* In the paper of Pani & Fornasini (1990) the inverse-ThCr₂Si₂type slab was labelled BaAl₄-type slab which is an equivalent formulation because the ThCr₂Si₂ type is a substitution derivative of the BaAl₄ type. The CaF₂-type slab was cited as ZrSi₂ segment by Konyk *et al.* (1988), ZrSi₂ being an intergrowth of CaF₂- and AlB₂-type slabs.

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Th Cr_2Si_2 -type slab where the atoms on the *a* sites have been completely removed.

The second vacancy variant of the SmNiGe₃ type has been reported for the pseudobinary compound Ce₂(Ge_{0.9}Ge_{0.1})₇ with space group *Cmca* (Yarmolyuk, Pecharskii, Gryniv, Bodak & Zavodnik, 1989), for which half of its unit cell $(0 \le x < \frac{1}{2})$ is shown in a projection along [100] on the left-hand side of Fig. 1(b). The atom arrangement in the other half of the unit cell $(\frac{1}{2} \le x < 1)$ is identical to the one shown except for a shift by $\frac{1}{2}$ **b**, as required by the *C*-Bravais lattice. Owing to the ordering of the vacancies the **b** and **a** vectors of Ce₂(Ge_{0.9}Ga_{0.1})₇ are twice as long as the corresponding **a** and **c** vectors of SmNiGe₃. The Ce₂(Ge_{0.9}Ga_{0.1})₇ structure can also be considered as an intergrowth of three kinds of slabs along the [001] direction:

(a) The Po-type slabs are deformed and built up of X atoms ($X = Ge_{0.9}Ga_{0.1}$).

(b) The Ba[]Al₃-type slabs, containing rare earth and X atoms, have completely ordered vacancies. The square antiprism of composition Ce_4X_4 around the central X atom (being not on the interface with the Po-type slab) is expanded due to the X-atom displacements on the interface.

(c) The AlB₂-type slabs also consist of Ce and X.

atoms with the X atoms at the centres of the trigonal



Fig. 1. (a) Projections of SmNiGe₃ along direction [001] and of Ce₂CuGe₆ along [100]. Slabs of parent types which are used to build these structures are indicated beside the drawings. (b) Projections of Ce₂(Ge_{0.9}Ga_{0.1})₇ along [100] for $0 \le x < \frac{1}{2}$ and of La₂Al_{1+x}Ge_{6-x} along [010] for $0 \le y < \frac{1}{2}$. Slabs of parent types which are used to build these structures are indicated beside the drawings. The BaAl₄-type slabs with vacancies are denoted as Ba[]Al₃ and the inverse-ThCr₂Si₂-type slabs with vacancies as inverse-ThCr[]Si₂.

Ce prisms. The X atoms are slightly displaced from their ideal positions.

In one unit cell the slabs are stacked in the sequence $Po-Ba[]Al_3-AlB_2-Ba[]Al_3-Po-Ba[]Al_3-AlB_2-Ba[]Al_3.$

The new La₂Al_{1+x}Ge_{6-x} structure is also a vacancy variant of the SmNiGe₃ structure, and the vacancies are also regularly distributed over all inverse-ThCr₂Si₂-type slabs. A projection of the La₂Al_{1+x}Ge_{6-x} structure along [010] for half of one unit cell ($0 \le y < \frac{1}{2}$) is shown on the right-hand side of Fig. 1(b). The atom arrangement in the other half of the unit cell ($\frac{1}{2} \le y < 1$) is identical, except for a shift by $\frac{1}{2}a$, as required by the C-Bravais lattice. Also here the ordering of the vacancies leads to a doubling of the **a** and **b** vectors as compared to the corresponding **a** and **c** vectors of SmNiGe₃. One recognizes that the La₂Al_{1+x}Ge_{6-x} structure can be considered as an intergrowth of three kinds of slabs:

(a) The Po-type slabs are deformed and built up of X atoms [X(1), X(2) and X(3)], *i.e.* Ge atoms partially substituted by Al atoms.

(b) The inverse-ThCr[]Si₂-type slabs have rareearth atoms, aluminium atoms on a sites and Xatoms (essentially Ge with a small substitution of Al) on t sites. In the slabs only one of two possible a sites is occupied, the vacancies being arranged in an ordered way. The X atoms are slightly displaced from their ideal t sites so that they are closer to an unoccupied a site and further away from an occupied a site which leads to an expanded square antiprism of composition La₄X₄ around the Al atom.

(c) The AlB₂-type slabs consist only of La, Ge(1) and Ge(2) atoms with the Ge atoms at the centres of the trigonal La prisms. The Ge atoms are slightly displaced from their ideal positions.

In one monoclinic unit cell of $La_2Al_{1+x}Ge_{6-x}$ four slabs are intergrown along the direction perpendicular to the (001) plane. Their stacking sequence is Po-inverse-ThCr[]Si₂-AlB₂-inverse-ThCr[]Si₂.

As a consequence of the deformations with respect to the SmNiGe₃ type, observed essentially in the planes forming the Po-type slab, the coordination of the sites forming these planes has been modified. It can be seen from Table 2 that sites X(1), X(2) and X(3) are all surrounded by four small atoms (3X +1 Al), a coordination which should be compared to the environment of the corresponding Ge site in SmNiGe₃ (2 Ni + 5 Ge). The coordination of the Al site, ignoring contacts with rare-earth atoms, is a square pyramid (1 Ge + 4X), similar to that of the Ni site in SmNiGe₃ (5 Ge) and of the corresponding site in ThCr₂Si₂.

The Ce₂(Ge_{0.9}Ga_{0.1})₇ and La₂Al_{1+x}Ge_{6-x} structures can be considered as slab stacking variants. Fig. 2 demonstrates schematically how the monoclinic La₂Al_{1+x}Ge_{6-x} type (cell vectors \mathbf{a}_M , \mathbf{b}_M , \mathbf{c}_M) can be obtained from the orthorhombic $Ce_2(Ge_{0.9}Ga_{0.1})_7$ type (cell vectors \mathbf{a}_O , \mathbf{b}_O , \mathbf{c}_O) by slicing the latter along the (001) planes and shifting successive slabs by $\frac{1}{2}\mathbf{b}_O$. The new atom arrangement, which corresponds to the $La_2Al_{1+x}Ge_{6-x}$ type, can be described with the monoclinic cell shown with dotted lines. For the idealized structures the following relations can be derived from Fig. 2 (ignoring the origin shift): $\mathbf{a}_O = \mathbf{b}_M$, $\mathbf{b}_O = -\mathbf{a}_M$ and $\mathbf{c}_O = \frac{1}{2}\mathbf{a}_M + 2\mathbf{c}_M$ and further $\sin(\beta_M - 90^\circ) = |\mathbf{a}_M|/4 \cdot |\mathbf{c}_M|$.

Inverse-ThCr []Si₂ slabs with an ordered vacancy arrangement (requiring a doubling of two translation periods) have also been observed in Lu₅Co₄Si₁₄ (Chabot & Parthé, 1986) and Y₉Os₄Si₂₀ (Gueramian, Chabot, Yvon, Schellenberg & Braun, 1988) with Co or Os atoms centring the $Lu(Y)_{a}Si_{a}$ square antiprisms. In both structures these slabs are intergrown with AlB₂-type slabs, as in La₂Al_{1+x}Ge_{6-x}, and with slabs of a third kind. The deformation features of the inverse-ThCr[]Si₂-type slabs in these two silicides are similar to those observed in the $La_2Al_{1+x}Ge_{6-x}$ structure, *i.e.* the Si atoms have moved closer to an unoccupied a site and further away from an occupied a site. Disordered vacancies on a sites in inverse-ThCr₂Si₂-type slabs have been reported for several intergrowth structures, as for example Sm₄Co_{1-x}Ge₇



Fig. 2. Schematic slab stacking relation between the monoclinic $La_2Al_{1+x}Ge_{6-x}$ type (cell vectors \mathbf{a}_M , \mathbf{b}_M , \mathbf{c}_M) and the orthorhombic $Ce_2(Ge_{0.9}Ga_{0.1})_7$ type (cell vectors \mathbf{a}_O , \mathbf{b}_O , \mathbf{c}_O). By slicing the latter along the (100) planes and shifting successive slabs for $\frac{1}{2}\mathbf{b}_O$, the new atom arrangement corresponds to the $La_2Al_{1+x}Ge_{6-x}$ type. Its monoclinic translation lattice is shown with dotted lines.

(Mruz, Pecharskii, Bodak & Bruskov, 1987) or CeNiSi₂ (Dörrscheidt, Savelsberg, Stöhr & Schäfer, 1982; Chabot, Parthé & Steinmetz, 1986; François, Venturini, Malaman & Roques, 1990; Venturini, François, Malaman & Roques, 1990).

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La₂Al₃Ge₄ and Isotypes of the Orthorhombic Ba₂Cd₃Bi₄ Type, a Slab-Stacking Variant of the HfFe₂Si₂ Type

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Abstract. La₂Al₃Ge₄, $M_r = 649 \cdot 125$, orthorhombic, Ba₂Cd₃Bi₄ type, oS36, (64) $Cmca - f^2e^2a$, $a = 6 \cdot 146$ (2), $b = 15 \cdot 194$ (4), $c = 8 \cdot 037$ (2) Å, $V = 750 \cdot 4$ (2) Å³, Z = 4, $D_x = 5 \cdot 745$ Mg m⁻³, λ (Mo K α) $= 0 \cdot 71073$ Å, $\mu = 28 \cdot 318$ mm⁻¹, F(000) = 1124, T = 300 K, $wR = 0 \cdot 036$ for 472 contributing unique reflections. Isotypes are found for R_2 Al₃Ge₄ with R =Ce, Pr, Nd, Sm, Gd, Tb, Dy, Ho and Er. The Ba₂Cd₃Bi₄ type together with a branch, called the Hf₂Ni₃Si₄ type, can be considered as a slab-stacking variant of the HfFe₂Si₂ type. The change of stoichiometry from HfFe₂Si₂ to Hf₂Ni₃Si₄ is caused by the coalescing of two different Fe sites at the stacking border.

Introduction. The La-deficient part (< 35 at.% La) of the La–Al–Ge ternary phase diagram was investigated by Muravyeva & Zarechnyuk (1970). Three crystal structures of the five compounds reported had been known: LaAl₂Ge₂ has the CaAl₂Si₂ type (*anti*-Ce₂O₂S type) (Zarechnyuk, Muravyeva & Gladyshevskii, 1970), LaAl_{2-x}Ge_x ($0.2 \le x \le 0.5$) crystallizes with the AlB₂ type (Raman & Steinfink, 1967) and LaAlGe with the α -ThSi₂ type (or an ordered

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